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CRYOGENIC MIRROR ANALYSIS

S. Nagy

1. INTRODUCTION

Due to extraordinary distances scanned by modern telescopes, optical surfaces in such telescopes must be manufactured to unimaginable standards of perfection of a few thousandths of a centimeter. Upon what seems a perfectly ground and polished mirror, there will lie ripples, bumps, valleys, and a variety of aberrations and distortions. To detect these imperfections requires an intricately tuned optical system in conjunction with a phase-shift interferometer. The goal of the Astrophysical Experiments Branch group at NASA Ames was to be able to detect imperfections of less than 1/20 of a wavelength of light, for application in the building of the mirror for the Space Infrared Telescope Facility (SIRTF). Because the mirror must be kept very cold while in space, another factor comes into effect: cryogenics.

Cryogenics refers to very cold liquids or surfaces, such as liquid helium (4.2 Kelvin). Since the mirror that will be used in SIRTF must detect radiation in the infrared range, any stray radiation from the telescope facility would degrade the quality of the image received from outer space. For this reason, the mirror must be cleverly surrounded by various heat shields of liquid helium, liquid nitrogen, and reflective coatings. But like any other surface that is cooled, the mirror will bend and twist out of its normal shape. This results in erroneous images.

How does the mirror become distorted? Is there any way to correct its aberrations, so as to receive a clear image? How does the light energy reflect from a warped mirror? These are some of the questions that are being answered by Cryogenic Mirror Testing/Analysis. This paper describes the process to test a specific mirror under cryogenic conditions; including the follow-up analysis accomplished through computer work. To better illustrate the process and analysis, we will follow a Pyrex Hex-Core mirror (Photo 5) through the process (referring to it as Mirror 1A) from the laser interferometry in the lab, to computer analysis via a computer program called FRINGE.

FRINGE has been an integral part of the Cryogenic Mirror Analysis giving Ames Research Center a fairly advanced computational tool for the analysis of an interferogram (an image describing the characteristics of an optical surface), which is vital to SIRTF. FRINGE has served as a solution to the problem of quantifying test data so that surface profile and other optical characteristics can be quantitatively determined.

The program can be viewed as a collection of subroutines that the user can arrange to quantify a variety of test data and reduce it such that a high quality optical path difference (OPD) map is produced. With this map, other analysis subroutines can be used to test optic errors, perform image quality analyses, calculate aberration coefficients, determine residual errors, etc. (*Taken from FRINGE manual, Arizona Optical Sciences Center*)

2. MECHANICS OF THE ANALYSIS PROCESS

During this discussion of the lab set-up and procedure, refer to the diagrams and pictures in Appendix A and Appendix C, respectively. For analysis of how the mirror will perform under extreme cold conditions, it is first mounted to the bottom of the top section of the dewar assembly as seen in Photo 4. The mirror must be firmly and precisely mounted to avoid wobbling. The dewar assembly, as seen in Photo 3, is the apparatus by which the mirror can be cooled to nearly 4 Kelvin (liquid helium temperature) to simulate its environment in space. Diagram 1 is a section view of the entire dewar assembly as seen in Photo 3.

Once the test mirror has been attached, the bottom two components of the dewar are attached, and the cooling down process begins. The liquid helium and the liquid nitrogen tanks at the top of the dewar are filled, after the air is pumped out from between the walls of the dewar. The laser interferometer, Photo 2 and Diagram 2, has been turned on at this point and during the cooling of the mirror, the laser is manually kept the correct distance from the mirror to remain in focus, by use of a micrometer mount (on Diagram 2).

Carbon resistors placed on the mirror surface and the walls of the dewar, indicate the temperature. As the temperature approaches that of liquid helium (4.2 Kelvin), the interferometer is precisely focused so that a clear image exists. The path of the laser beam is as follows. (Refer to Diagram 2.) First the laser beam, generated by a Helium-Neon Laser, passes through an aperture to filter out any scatter radiation or fuzziness. Then the beam passes through a microscope objective, which concentrates and narrows the beam, toward a beam-splitter cube where the majority of the light is reflected upward toward the test mirror through a window opening in the bottom of the dewar assembly.

Let us imagine that the light travels upward toward the mirror in small packages. Upon reaching the mirror, the light is reflected. Note that the light, however, may not be returning along the same path as when it was traveling toward the mirror, because the mirror may be warped from the cryogenic conditions. The reflected package of light meets with one of the packages of light that have been reflected downward by the beam-splitter cube. Ideally, the two packages should coincide, but because the reflected package of light is distorted, the two packages do not always mesh. In the areas where they do not mesh, they neutralize each other. This is called destructive interference, thus producing dark lines on the interferogram (Photo 1). These streaks are named fringes.

The light zones are where the two packages of light did not cancel each other. Once the fringe pattern is in focus, a photograph is taken. This is the point at which the fringe analysis via computer begins.

Photographs taken in the laboratory of the interference fringe pattern are digitized by an Apple IIe and HiPad digitizing tablet. The photo is placed on the tablet, where the fringe lines are manually entered into the computer, fringe by fringe until the image on the computer screen resembles the pattern on the photograph. At this point,

the computer converts the digitized coordinates into three-digit x/y coordinates (inch measurements without the decimal point). A hard copy of these coordinates is then generated for manual data entry into the VAX mainframe computer via a Tektronix terminal.

The digitized x/y coordinates of the fringe pattern are entered into the VAX as a file, each line having the x/y coordinates for a certain fringe. Various options are open to the user, depending on the type of mirror being used and the type of output desired. The following commands initiate the setting of parameters that can affect the output from the FRINGE program:

- a. WEDGE: specifies the frequency of fringes to be scanned
- b. COBS n : n is the fraction of the mirror radius represented by the hole
- c. STEP: defines the contour interval for the contour map (fraction of wavelengths)
- d. WIDTH: defines the fraction of the contour interval in which the characters will be printed, ranging from 0 to 1 where 0 will print characters only when they are identical to the contour value; a width of 1 will print characters at every position and the map will be filled with print (see RESULTS AND WHAT THEY MEAN, Contour Map).

3. RESULTS AND WHAT THEY MEAN

Once the data have been entered and the parameters have been set, FRINGE is run. A typical hard copy of the results from the calculations is included in Appendix B. Some of the important pieces of information are:

- a. STREHL RATIO: a measure of how close the mirror is to the ideal, with 1 being the ideal; defined as: given r = RMS Surface Error
- b. RMS SURFACE ERROR: root of the means of the squares of the Zernike polynomial coefficients; defined as:
- c. CONTOUR MAP: a top view of the mirror surface showing the peaks and valleys, much like a topographic map, using the letters A-N for decreasing mirror surface, and the letters P-Z for increasing mirror surface
- d. ZERNIKE POLYNOMIAL COEFFICIENTS: the terms of an endless series (truncated to 36 terms for practical purposes) that represents the aberrations found on the mirror surface

In addition to alphanumeric output, we have the option to generate color graphic plots. They are RED, GSPOT, and 3D Plot of Aberrations, as found in Appendix D. All of these plots have been created from the Zernike polynomial coefficients calculated on Mirror 1A. Refer to the first set of plots (Group I) in Appendix D during the discussion of the three different types of plots. They represent general plots of all the contributions obtained from Mirror 1A.

The first plot, 1A, describes the physical topography of the mirror surface in an exaggerated fashion. It provides for a visual understanding as to how all the aberrations combine to distort the mirror surface. Subsequently, the aberrations that combine to create the mirror surface, can be broken down, isolated, and categorized as being one of the following: Radial (Spherical), 1θ (Coma), 2θ (Astigmatism), 3θ , 4θ , and 5θ . We will look at all the distortions of Mirror 1A, except 5θ because of its negligible contribution in this case.

Plot 1B is referred to as GSPOT (Geometric Spot Diagram), which is the result of a Geometric Ray Analysis showing the intersection of approximately 640 rays with the image plane and as a radial energy distribution function.

The last type of plot, the Radial Energy Distribution plot (RED) depicts the energy concentration percentage at a given radius from the center of the mirror. This is the energy that is reflected back from the mirror. Notice on Plot 1C the sudden decline of energy between 0.00 and 0.80. This is due to the COBS parameter which defines the mirror as having a central hole. Therefore, no energy is reflected in that region.

The Radial Contributions, Group II plots, reflect a wave-like distortion from the center out. Thus the name spherical. The distortion is symmetrical, as is evident from the 3D plot, and from the GSPOT diagram. Also note the slight dip in the rise of the Radial Energy Curve. This is also a result of the undulations present on the mirror surface. The Group III plots show the characteristics of Coma distortion, which is quite minimal in this instance as seen from Plot IIIA.

The 2θ and 3θ Contribution plots are similar in that they both characterize a "potato chip-like" aberration in which there are distinct, symmetrical highs and lows. Note that the 2θ has only two highs and two lows, whereas the 3θ has three highs and three lows. And lastly, the 4θ Contribution, Group IV, which lacks a very significant contribution.

4. THE FUTURE OF CRYOGENIC MIRROR ANALYSIS AT NASA AMES

Through Cryogenic Mirror Analysis, the SIRTF group at Ames has been able to study the way different mirrors distort under extreme cold conditions. Beryllium, glass, and pyrex mirrors of different shapes and sizes have been tested. The next step, yet untested, is to try to reconfigure a mirror in an optical manufacturing environment so that it will be an undistorted mirror at cryogenic temperatures. This can be accomplished by polishing the mirror at room temperature using the data acquired from cryogenic testing. Where a peak existed at cryogenic temperature, a valley would be pol-

ished at room temperature. And vice versa. Then, theoretically, when the mirror is cooled it would distort from a bad mirror surface at room temperature, to a perfect surface at cryogenic temperature. This is what remains to be discovered through intensive testing.

In addition to the next steps in mirror reconfiguration, a few lab improvements are being sought. Plans for a larger dewar to accommodate larger mirrors are in sight as well as the purchase of a real-time, phase-shift laser interferometry system that would increase the present accuracy of 1/20 of a wavelength to 1/50 of a wavelength, as well as avoiding the manual data entry into the VAX. With these plans in mind, Cryogenic Mirror Analysis Technology at Ames Research Center will become an even more powerful tool.

APPENDIX A: DIAGRAMS

APPENDIX B: COMPUTER PRINTOUT

APPENDIX C: PHOTOS

APPENDIX D: PLOTS

APPENDIX E: PROCESS FLOWCHART

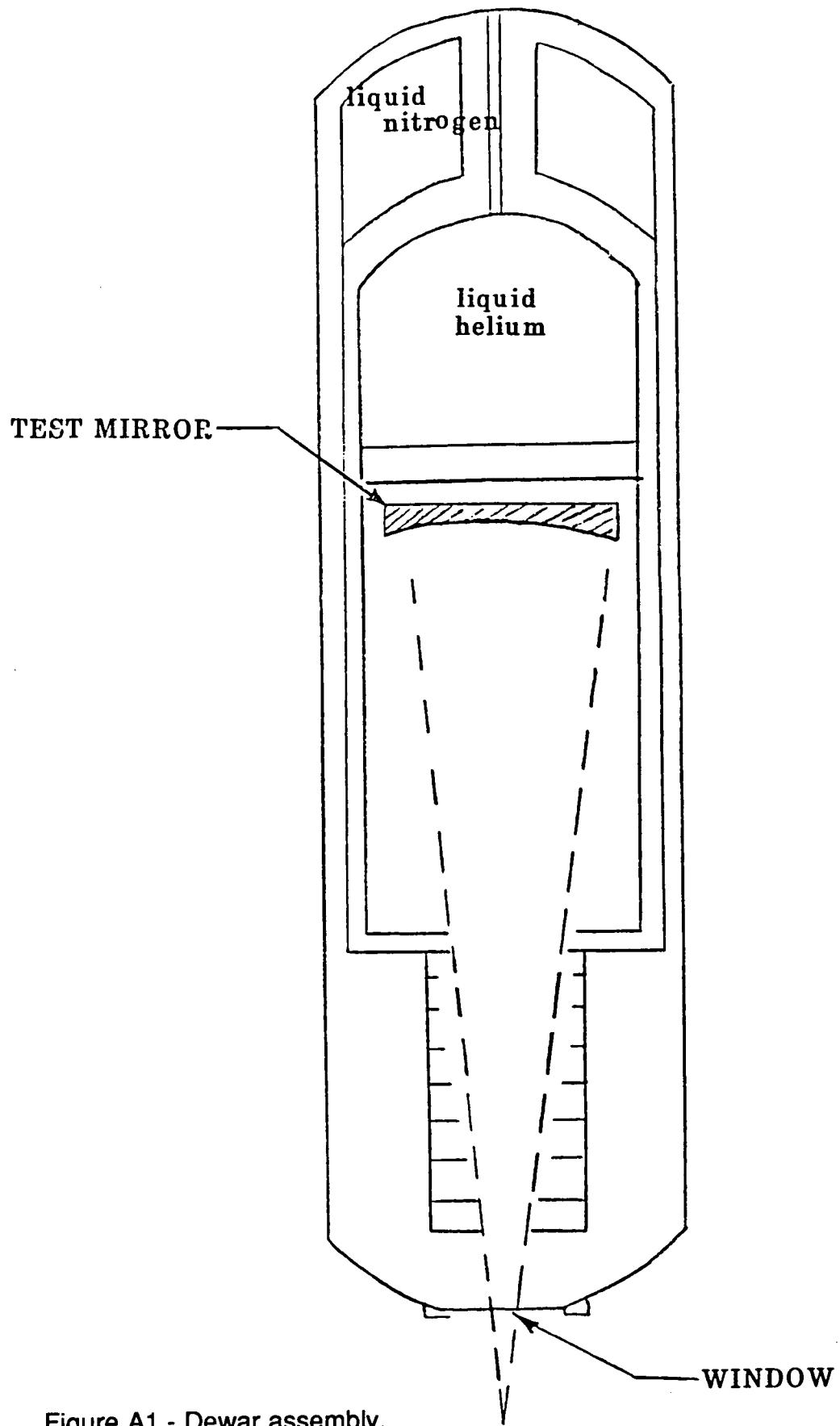


Figure A1.- Dewar assembly.

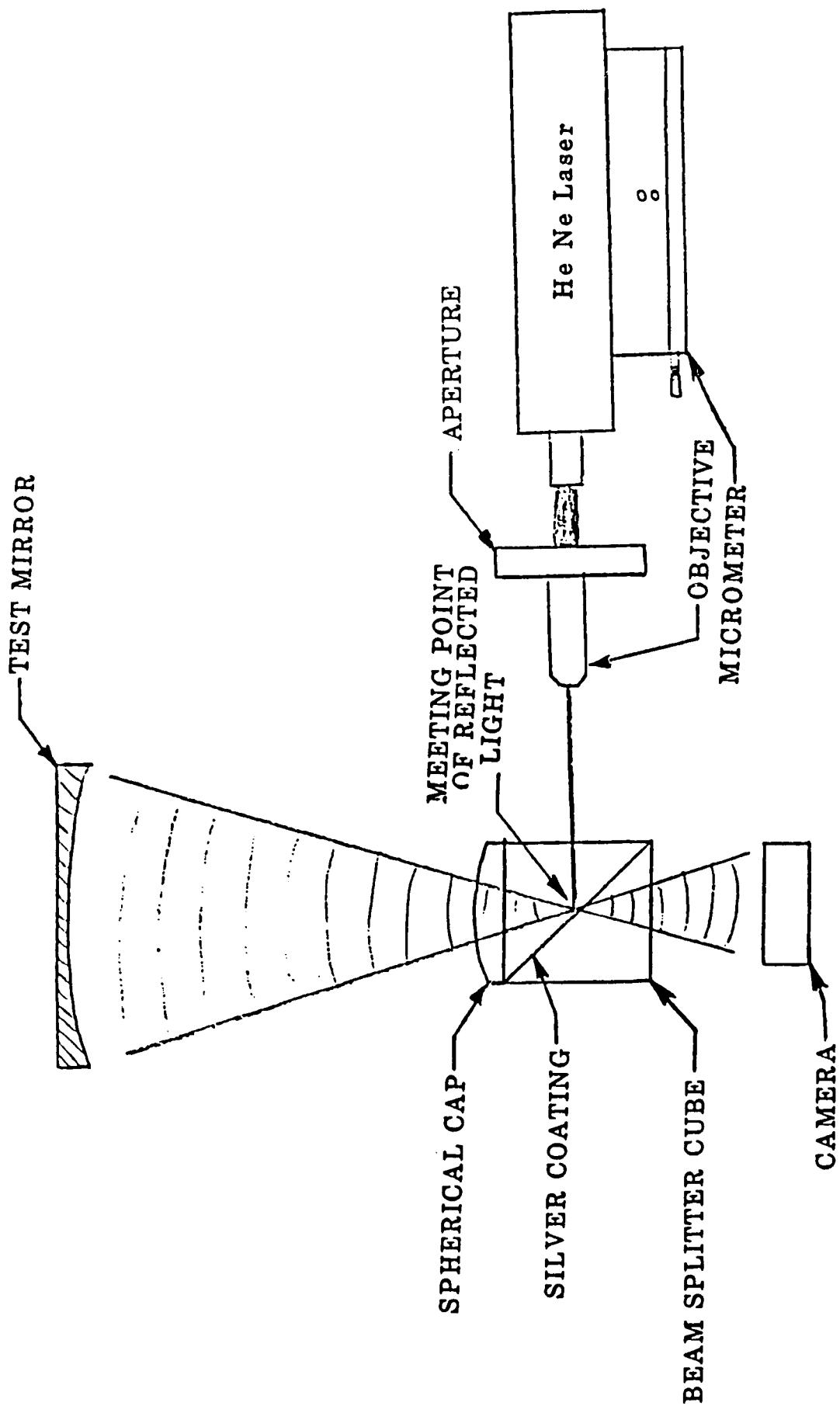


Figure A2.- Interferometer setup.

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 --LIST VERIFY
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 --WEDGE -.5
 --COBS .25
 --STEP .1
 --WIDTH .8
 --PART
 --FSCAN
 --END

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APERTURE MASKING
 TYPE CAX CAY COX COY
 ELIP 1.0000 1.0000 0.2500 0.2500

--1	538	192	506	181	470	177	433	172	399	173	371	179	343	181	325	182
--	END															
--2	562	209	523	205	480	204	435	206	391	208	350	209	313	212	276	223
--	248	232	214	248	END											
--3	628	265	605	247	572	238	545	240	516	238	485	240	458	244	432	249
--	395	244	360	245	318	250	279	256	249	263	219	268	192	278	175	290
--	END															
--4	650	294	613	282	528	274	488	276	443	274	368	280	289	289	202	305
--	153	335	END													
--5	674	340	658	323	633	321	604	319	558	312	514	311	471	312	425	316
--	381	319	341	323	304	327	265	333	227	343	187	354	159	369	143	382
--	131	400	END													
--6	681	383	647	373	548	357	503	352	462	354	410	358	363	363	307	367
--	267	371	236	378	197	395	171	403	146	416	128	437	END			
--7	692	436	656	420	611	413	578	406	541	399	502	395	464	397	423	402
--	388	405	339	408	295	412	255	421	209	438	176	450	152	466	136	479
--	134	500	END													
--8	695	476	614	459	574	448	540	442	489	442	436	443	405	446	383	450
--	365	455	344	354	297	456	270	465	240	479	211	486	181	499	156	513
--	146	533	141	552	END											
--9	684	536	648	520	597	499	499	487	453	493	397	497	363	500	335	495
--	308	500	283	512	251	527	226	535	205	548	183	558	166	573	159	577
--	END															
--10	668	576	579	557	508	533	467	537	427	540	375	540	346	545	308	554
--	278	564	243	580	214	589	191	592	179	605	END					
--11	635	629	600	618	551	605	507	598	456	588	401	586	347	596	305	609
--	269	616	240	627	224	642	215	653	END							
--12	577	686	568	668	510	651	472	646	437	645	403	649	368	650	314	660
--	281	666	269	677	267	686	265	697	END							
--13	495	727	466	712	412	700	387	704	363	709	355	721	366	740	END	

END OF DATA

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 XC YC RAD
 414.7500 454.5000 286.4809

Figure B1.- Computer printout 1.

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FRINGE VERIFICATION

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Figure B2.- Computer printout 2.

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WAVEFRON DEVIATION IN UNITS OF WAVES
TILT AND DEFOCUS MEASURED FROM DIFFRACTION FOCUS
WAVELENGTH λ .633 MICRONS

	N	RMS
RAW	0	1.676
PLANE	2	0.247
SPHERE	3	0.115
4H ORDER	8	0.107
6H ORDER	15	0.098
8H ORDER	24	0.088
COMPLETE	36	0.086

STREHL RATIO 0.592 AT DIFFRACTION FOCUS

FOURTH ORDER ABERRATIONS

MAGNITUDE	ANGLE	DESIGNATION
WAVES	DEG	
3.136	-94.8	TILT
0.687		DEFOCUS
0.083	0.3	ASTIGMATISM
0.138	-161.2	COMA
0.354		SPHERICAL ABERRATION

FOLLOWING TERMS WERE SUBTRACTED FROM DATA-

TILT FOCUS

PESIDUAL WAVEFRON VARIATIONS EVALUATED AT DATA POINTS

PTS	RMS	MAX	MIN	SPAN	STREHL
169	0.118	0.368	-1.094	1.463	0.575

PESIDUAL WAVEFRON VARIATIONS OVER UNIFORM GRID

PTS	RMS	MAX	MIN	SPAN	STREHL
652.	0.061	0.258	-0.144	0.402	0.863

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RMS CALCULATED FROM ZERNIKE COEFFICIENTS=0.064

Figure B3.- Computer printout 3.

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CONTOUR	STEP	WIDTH	PAGE	SIZE	-M-	-N-	-P-	-Q-
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ZERNIKE POLYNOMIAL COEFFICIENTS

0.0000	0.0000	0.0000	0.0541	0.0277	-0.0298	-0.0128	0.0349
-0.0267	0.1010	-0.0141	0.0221	-0.0015	0.0352	-0.0096	0.0219
-0.0208	0.0117	-0.0473	-0.0066	-0.0629	-0.0176	0.0040	0.0766
0.0044	0.0207	-0.0214	0.0012	-0.0492	-0.0035	-0.0155	0.0119
-0.0182	-0.0213	-0.0104	0.0028				

RESIDUAL WAVEFRON VARIATIONS OVER UNIFORM MESH

PTS RMS MAX MIN SPAN VOLUM
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END OF DATA

Figure B4.- Computer printout 4.

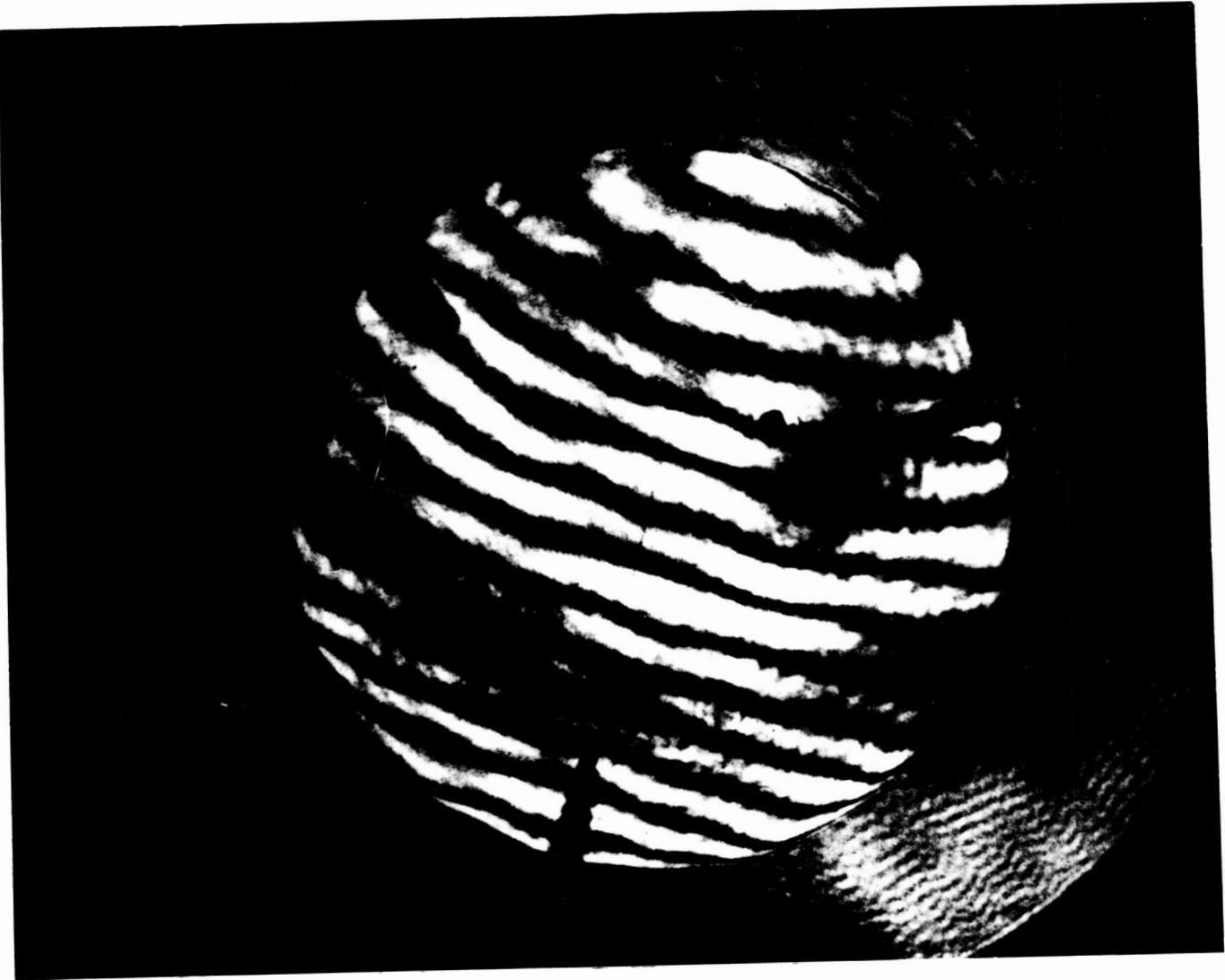


Figure C1.- Interference fringe pattern.

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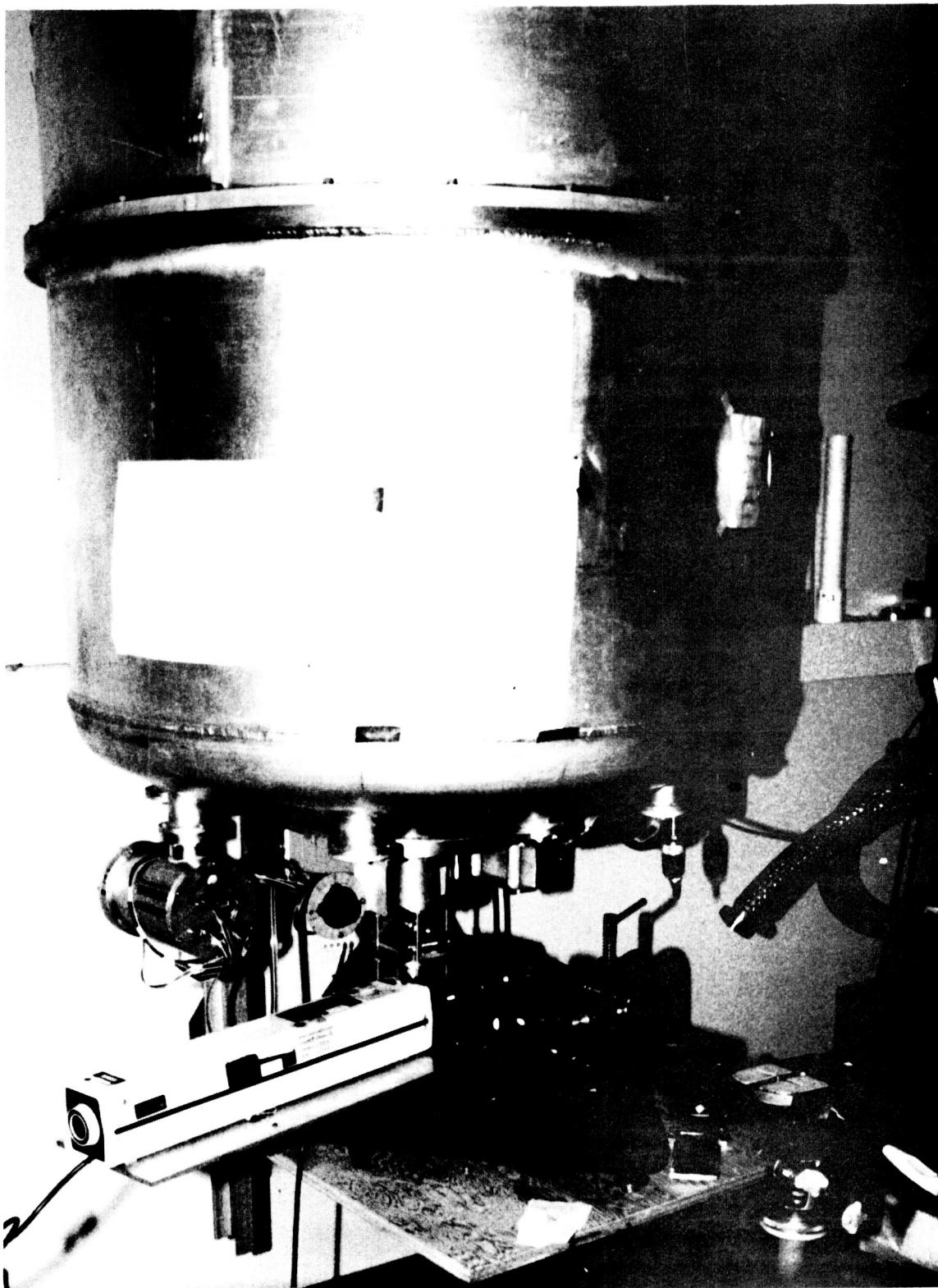


Figure C2.- Laser Interferometer with bottom of dewar.

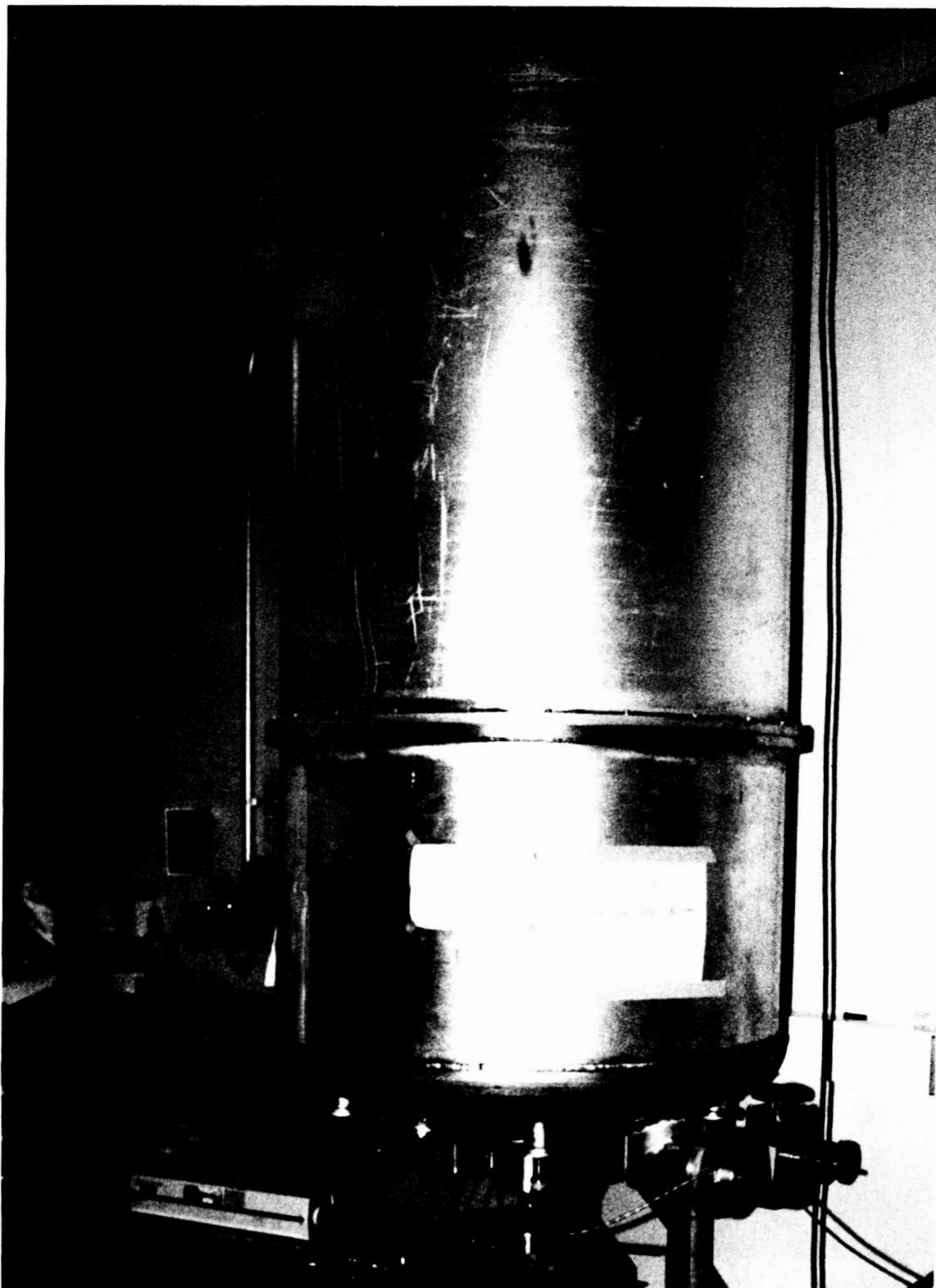


Figure C3.- Dewar assembly.

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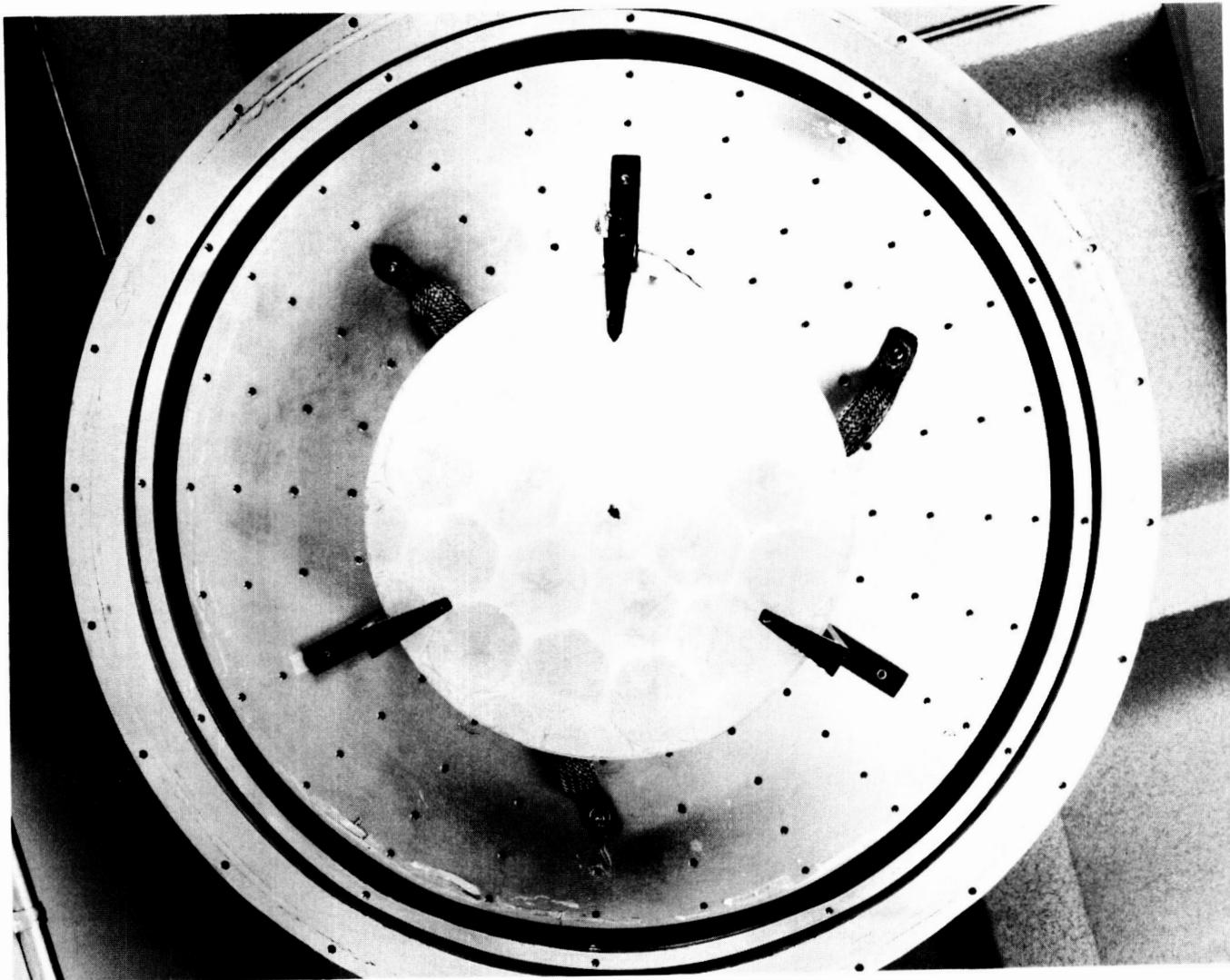


Figure C4.- Pyrex Hexcore Mirror 1A mounted to bottom of dewar assembly.

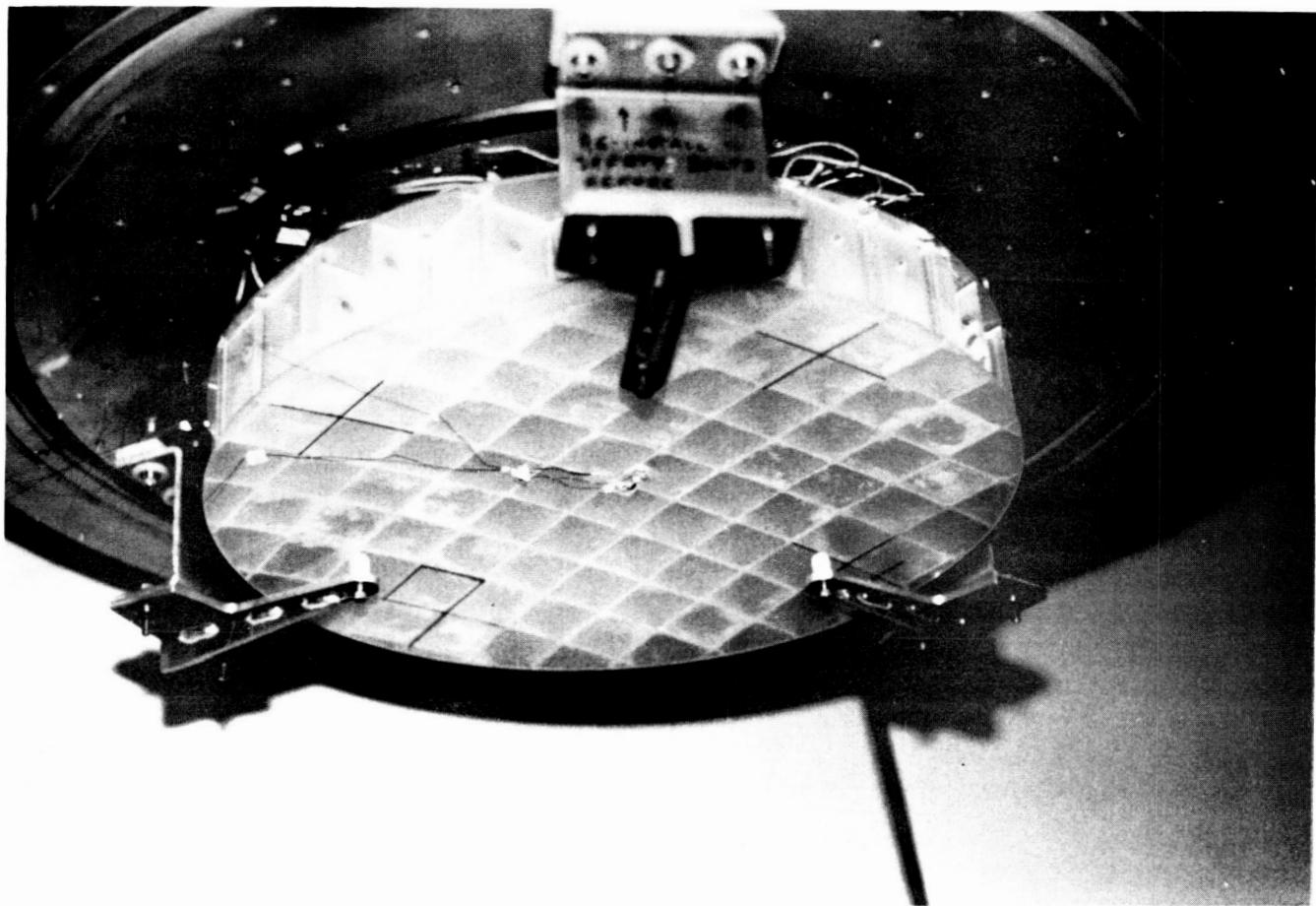


Figure C5.- Fused silica ultralightweight frit-bonded mirror.

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All Zernike Coefficient Contributions

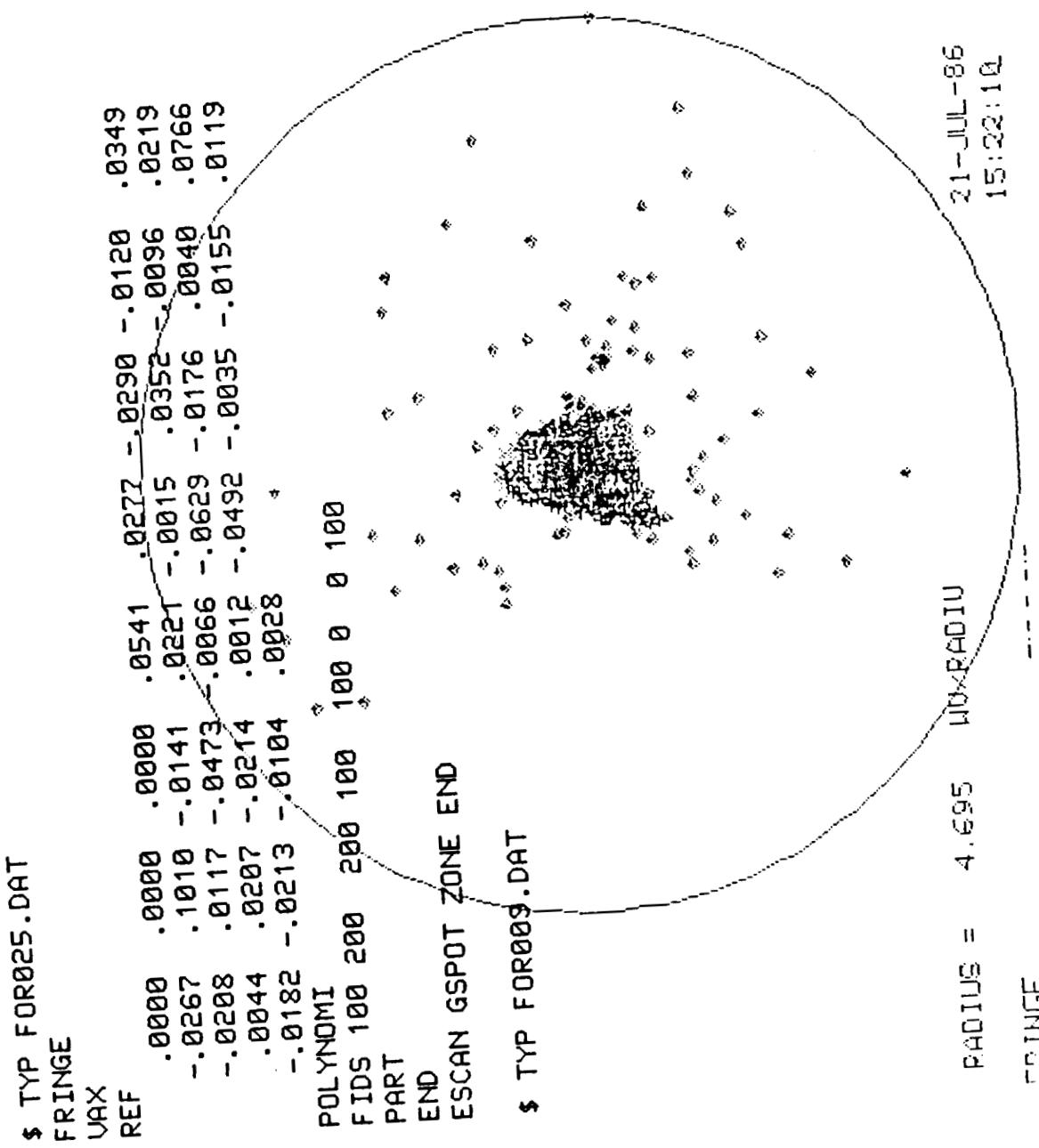
IA

GROUP I

WAVEFRONTVUES RADIUS

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Figure D1.- Plot IA.



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Figure D2.- Plot IB.

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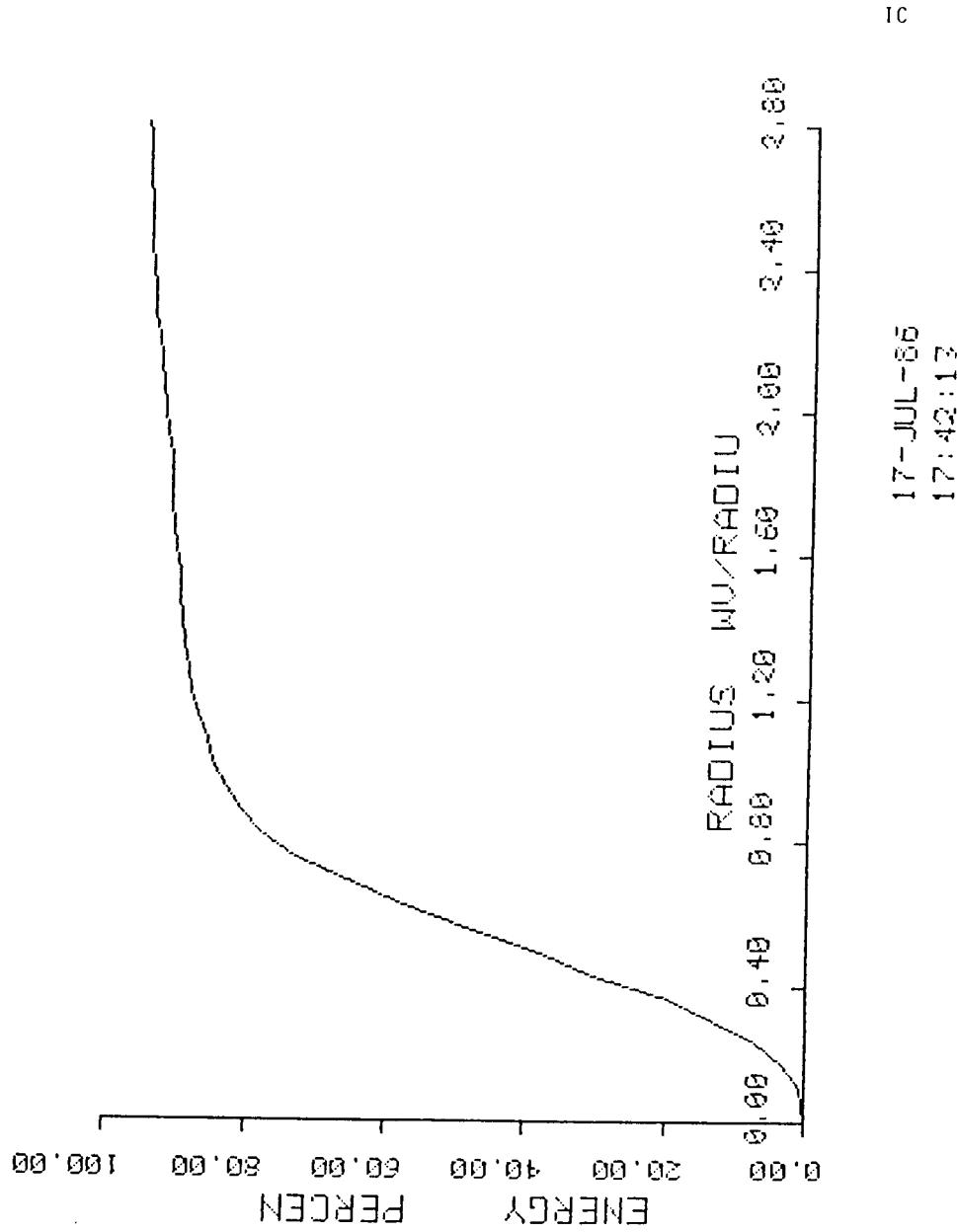


Figure D3.- Plot IC.

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POLYNOMI

FIDS 410 528 612 330 412 134 213 332

WEDGE 0.5

STEP .1

WIDTH .4

COBS .25

PART

END

DANA WAMAP PLOT3D END
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LAUEFRONTVALUES RADIUS

Radial Contribution (spherical aberration)

II A

GROUP II

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Figure D4.- Plot II A.

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IIB

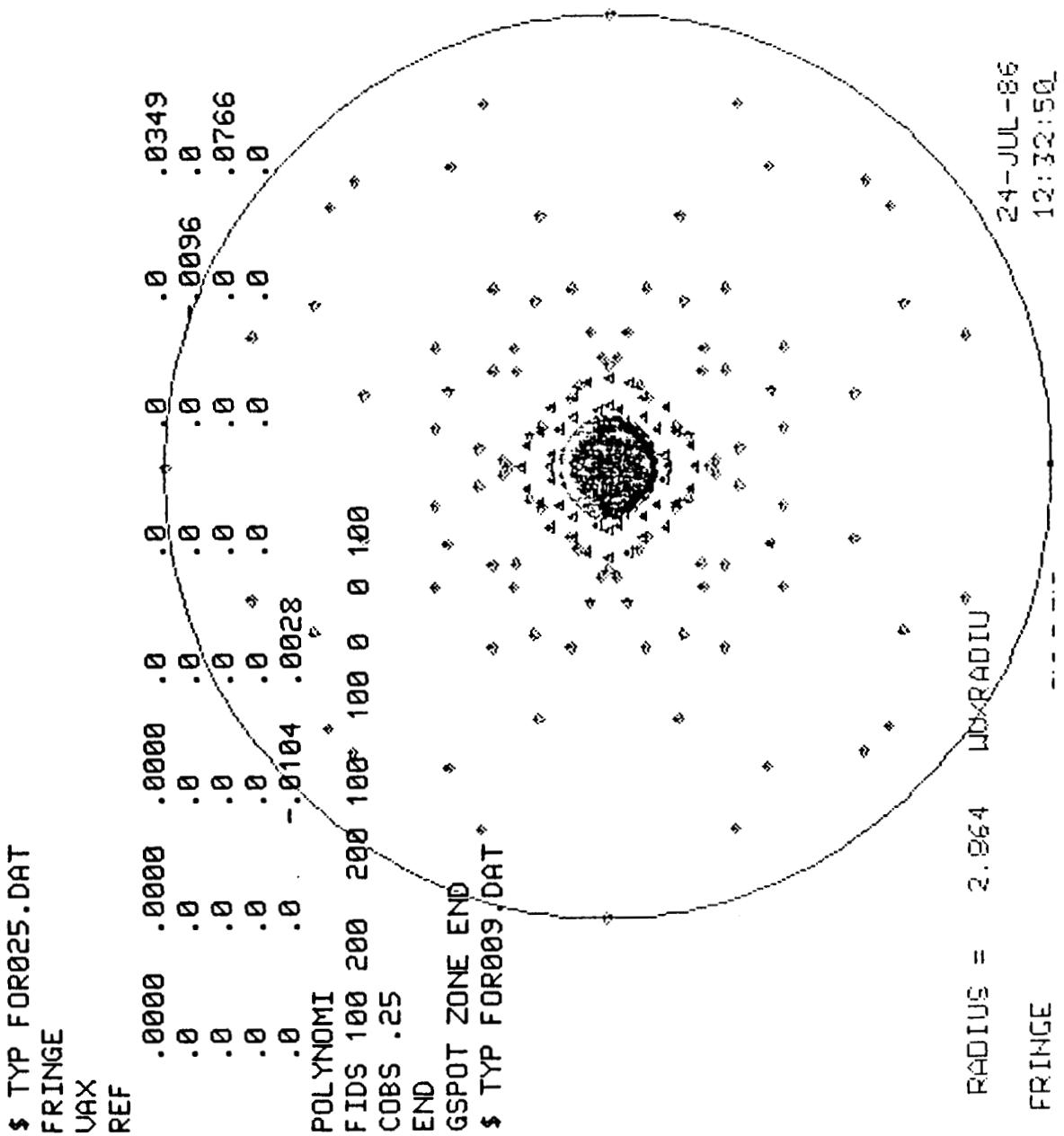
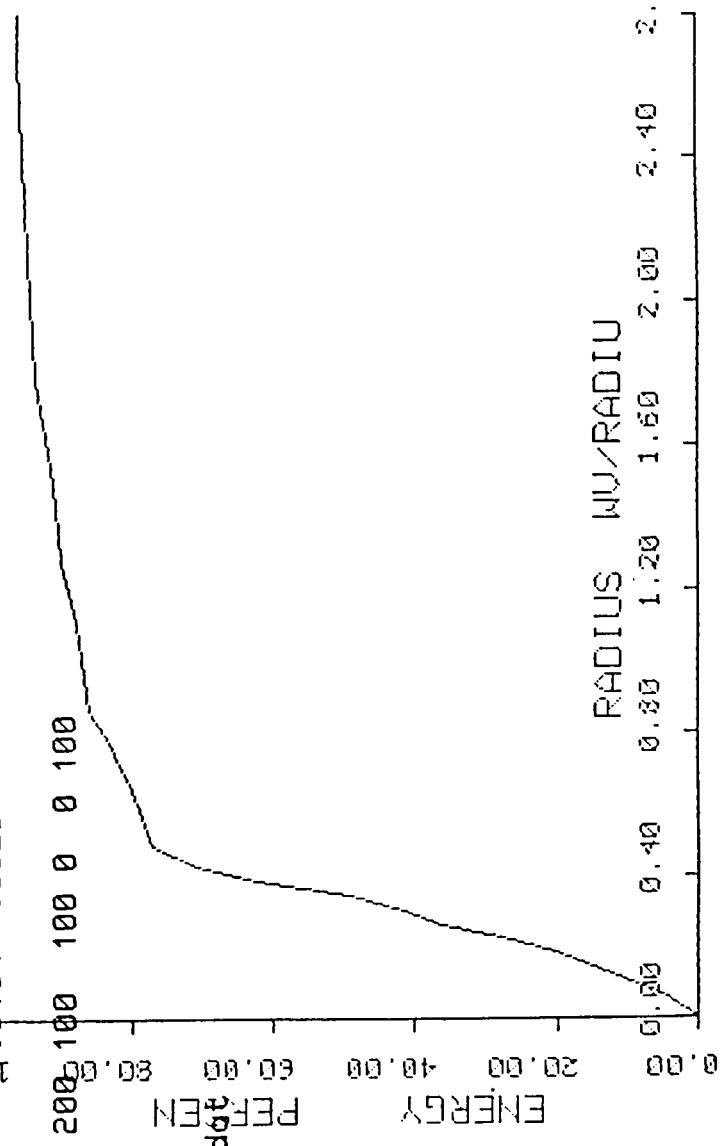


Figure D5.- Plot IIB.

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POLY NOMI
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Figure D6.- Plot II C.

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10 Contribution (coma)

GROUP III

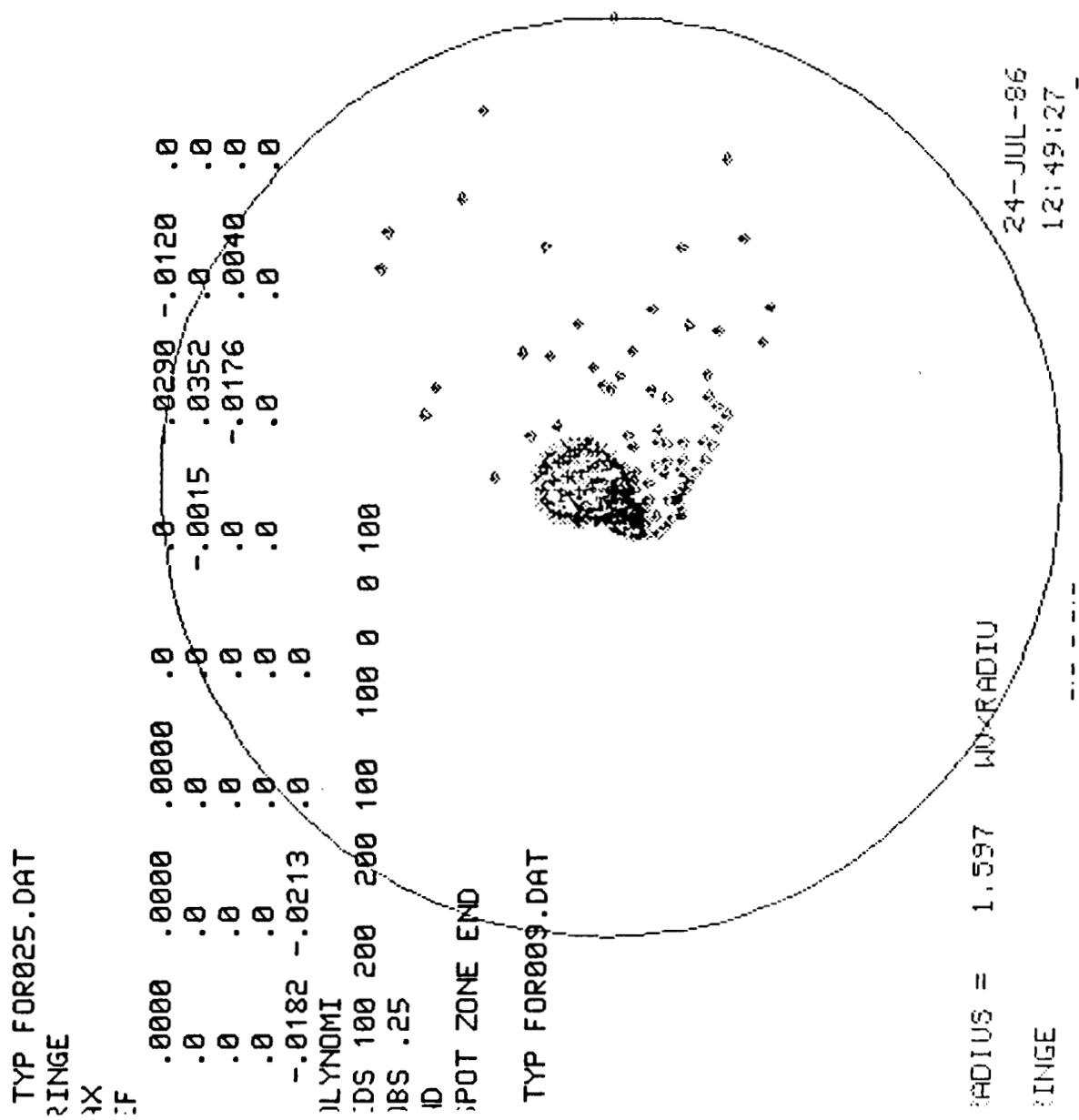
III A

WAVEFRONTHUES RADIUS

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Figure D7.- Plot IIIA.

III B



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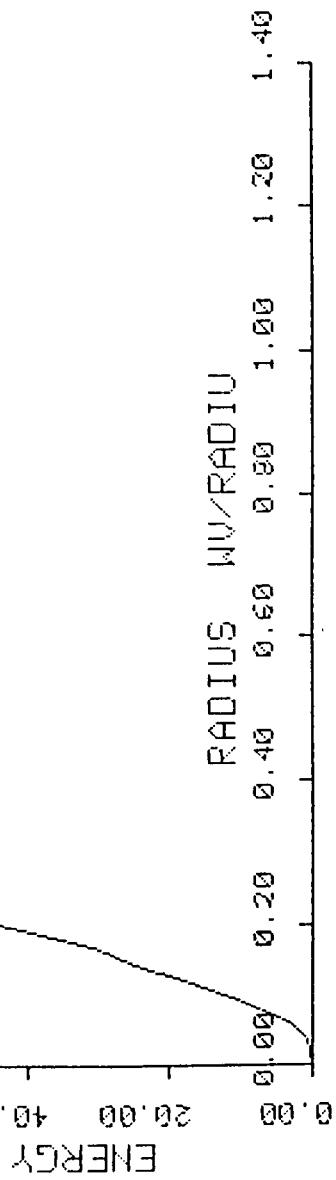
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FRINGE

III C

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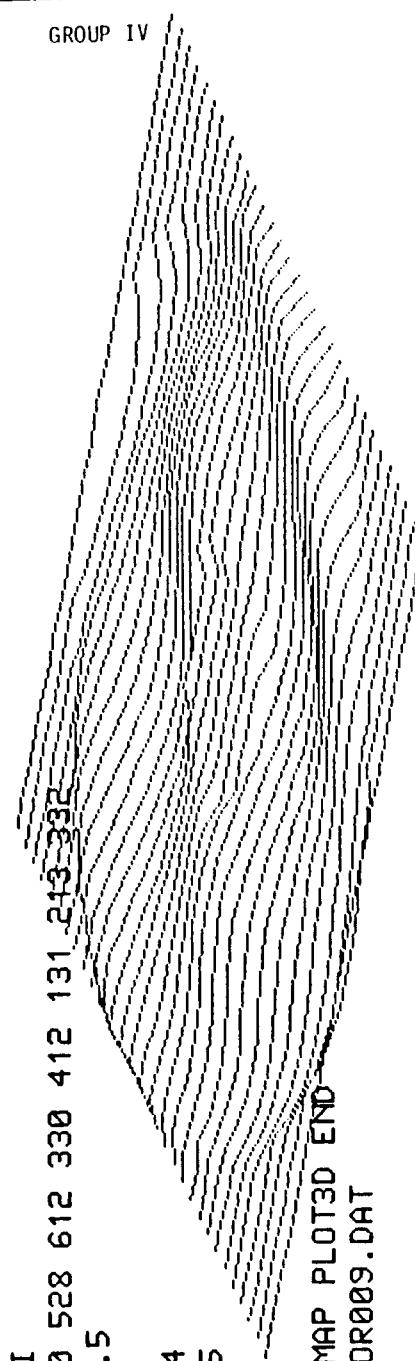
Figure D9.- Plot III C.

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.0000 .0000 .0000 .0000 .0000 .0000 .0000 .0000
POLYNOMI
FIDS 410 528 612 330 412 131 243 332
WEDGE 0.5
STEP .1
WIDTH .4
COBS .25
PART
END
DANA WAMAP PLOT3D END
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2θ Contribution (astigmatism)

GROUP IV



WAVEFRONTHAVES RADIUS

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Figure D10.- Plot IVA.

IV B

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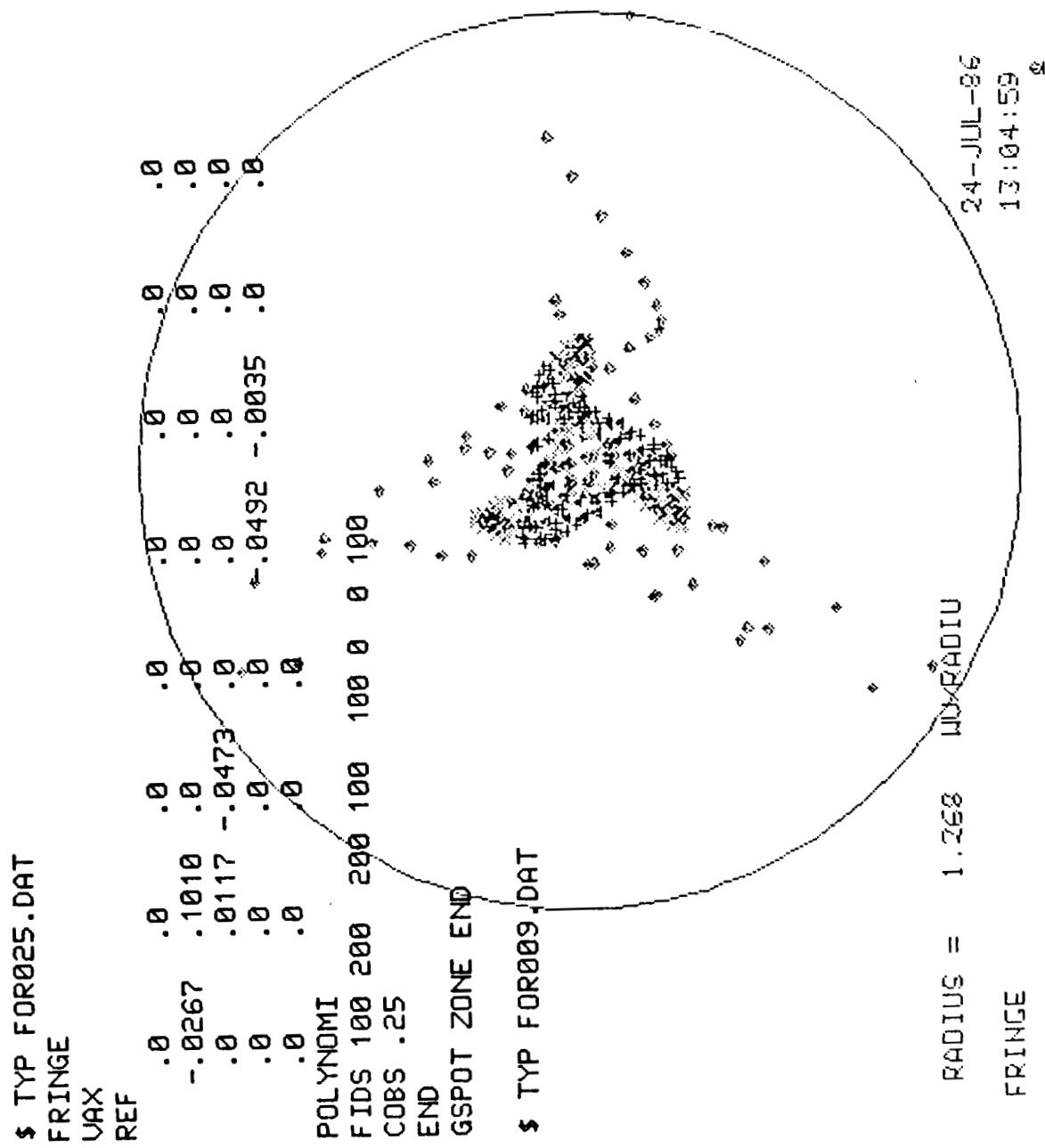


Figure D11.- Plot IVB.

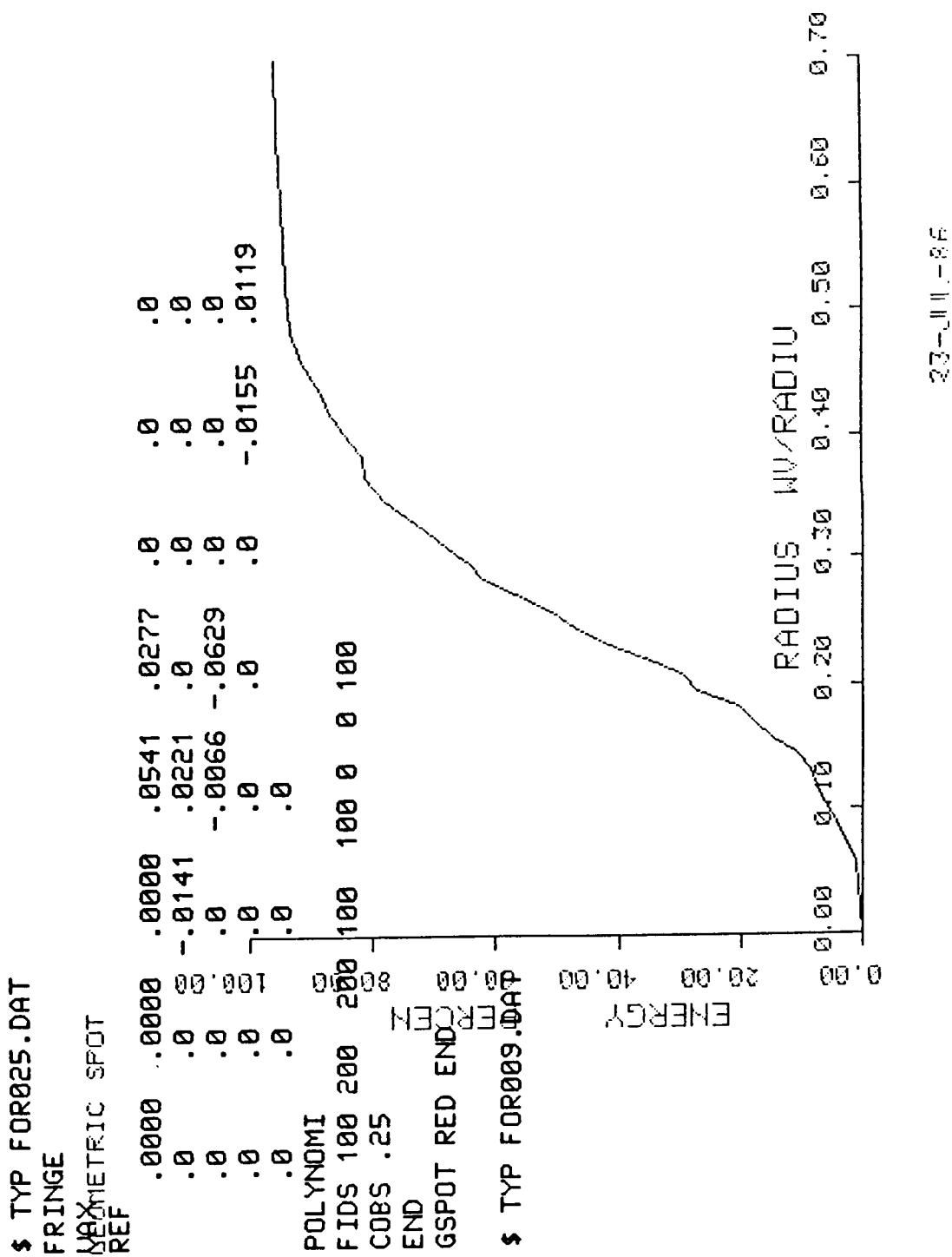
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Figure D12.- Plot IVC.

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.0000 .0000 .0000 -.0492 -.0035 .0000
.0000 .0000 .0000 .0000 .0000 .0000
POLYNOMI
FIDS 410 5E:: 612 330 412 131 213 332
WEDGE 0.5
STEP .1
WIDTH .4
COBS .25
PART
END
DANA WAMAP PLOT3D END
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3 θ Contribution

GROUP V

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V A

WAVEFRONTHAVES RADIUS

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Figure D13.- Plot VA.

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FRINGE
VAX

REF

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.0 .0 .0 .0 .0 .0 -.0155 .0119 .0
.0 .0 .0 .0 .0 .0 .0 .0 .0

POLYNOMI

FIDS 100 200

COBS .25

END

GSPOT ZONE END

\$ TYP FOR009.DAT

RADIUS = 0.898
FRINGE

WDRADII

24-JUL-86
12:57:27

V B

Figure D14.- Plot VB.

ORIGINAL PAGE IS
OF POOR QUALITY

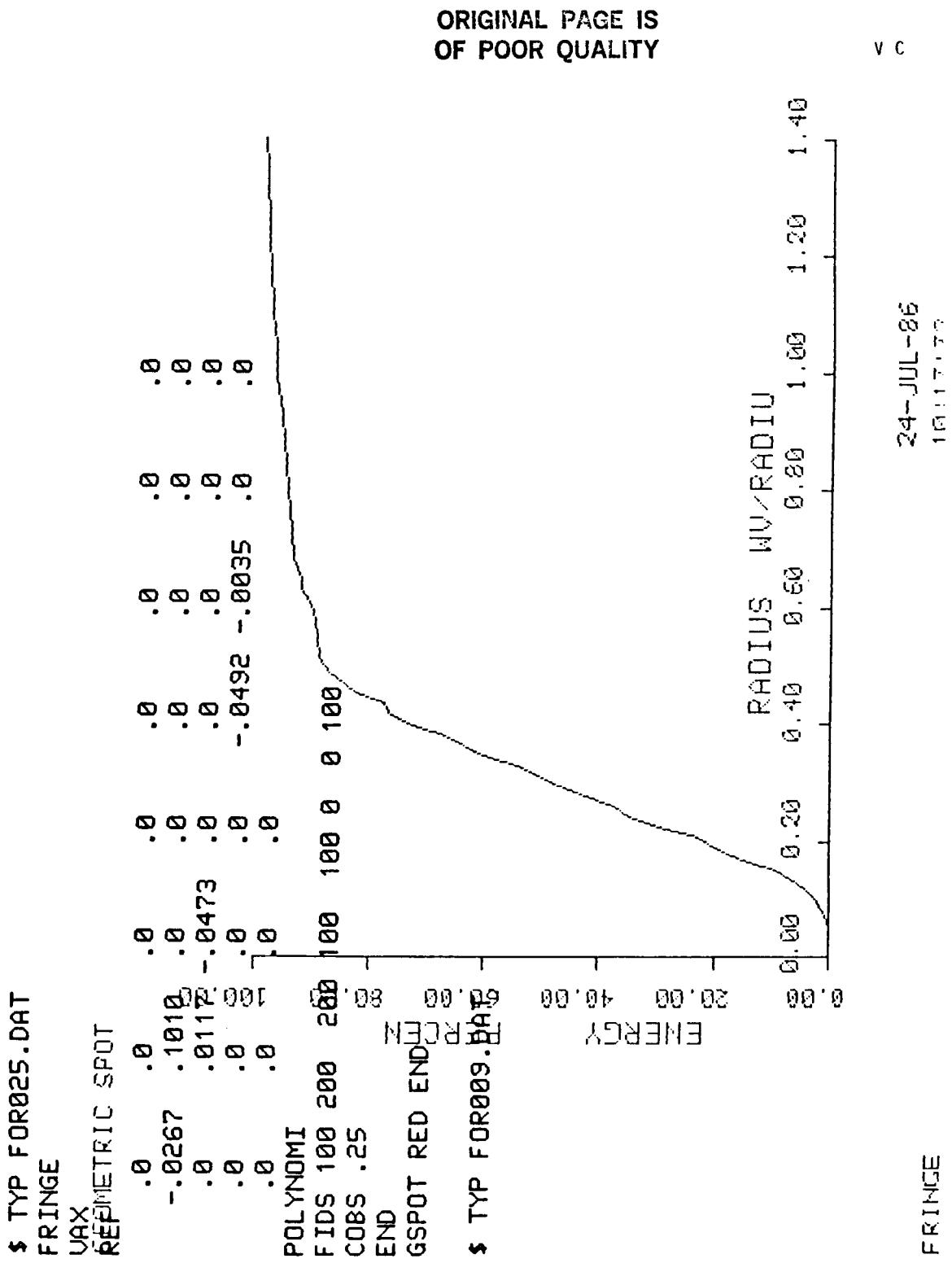


Figure D15.- Plot VC.

TYP FOR025.DAT

FRINGE
VAX
REF .0000 .0000 .0000 .0000 .0000 .0000
.0000 .0000 .0000 .0000 .0000 .0219
.0000 .0000 .0000 .0000 .0000 .0000
-.0208 .0000 .0000 .0000 .0000 .0000 .0000
.0000 .0000 -.0214 .0012 .0000 .0000 .0000
.0000 .0000 .0000 .0000 .0000 .0000 .0000

POLYNOMI

FIDS 410 528 612 33E 412 131 213 -332

LEDGE 0.5

STEP .1

WIDTH .4

COBS .25

PART

END

DANA WAMMAP PLOT3B-TEN

\$ TYP FOR009.DAT

100

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WAVEFRONWAVES RADIUS

VI A

4 θ Contribution

GROUP ML

17-JUL-86
14:57:31

Figure D16.- Plot VIA.

VI B

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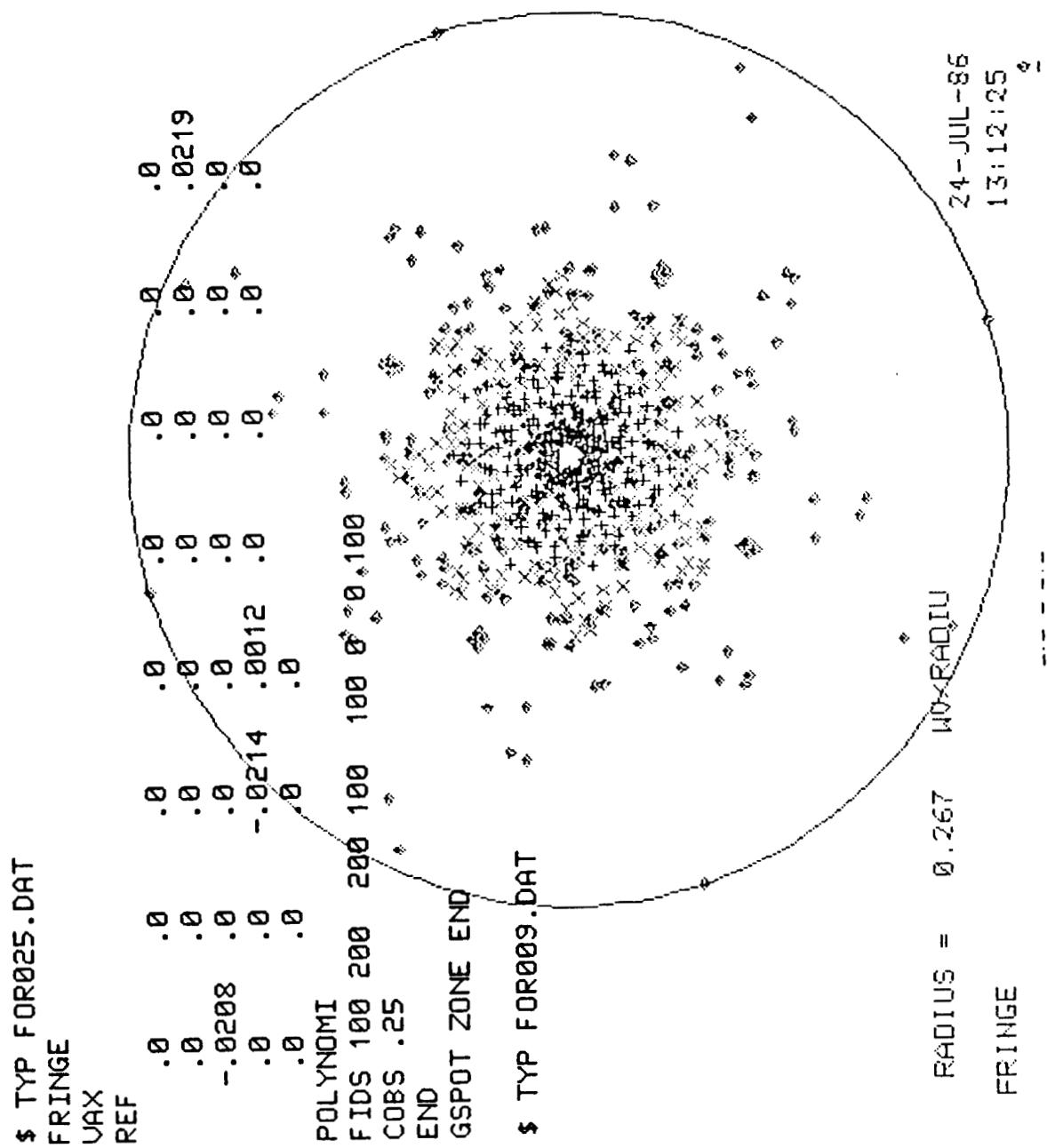


Figure D17.- Plot VIB.

\$ TYP FOR025.DAT
FRINGE
UAX EQUATORIAL SPOT
REF

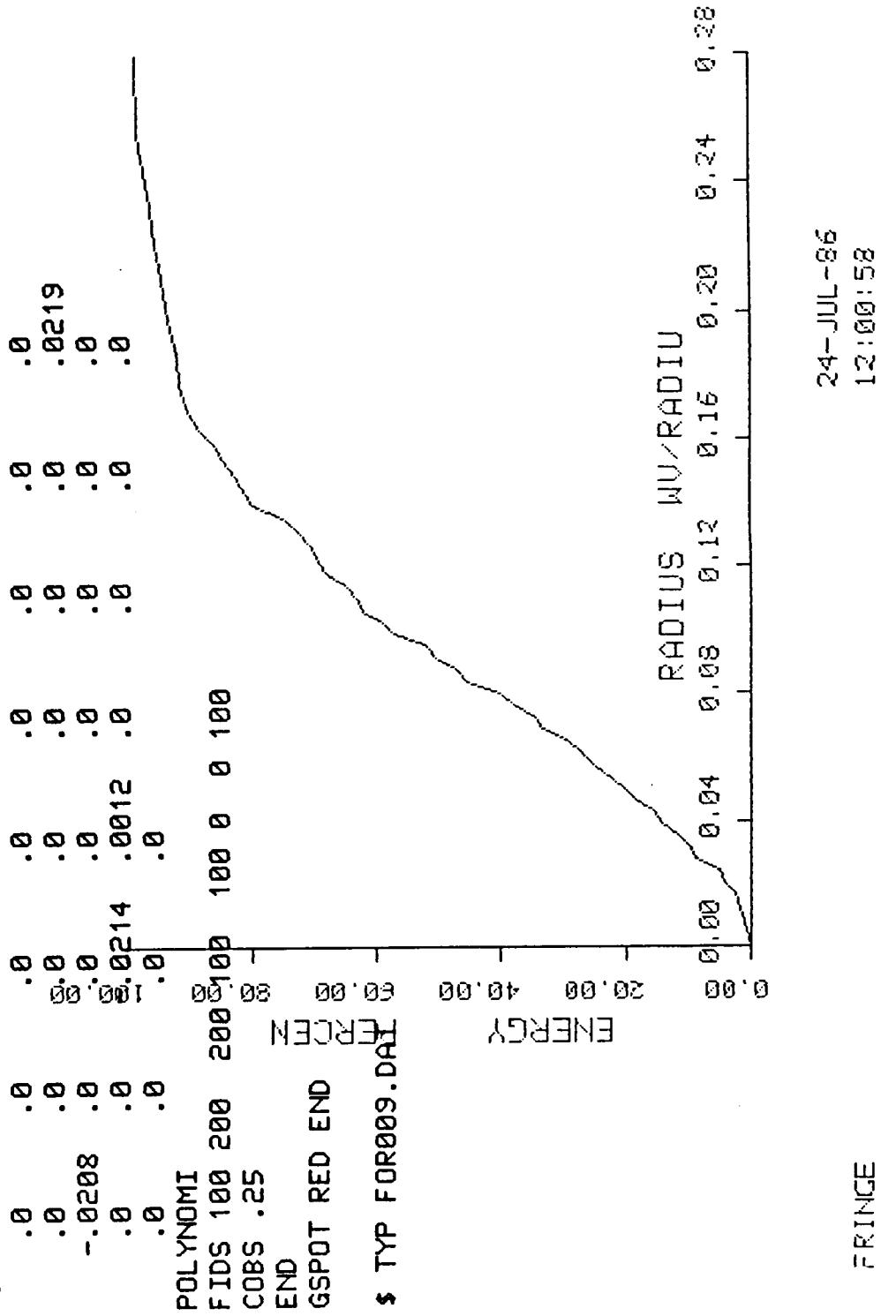


Figure D18.- Plot VIC.

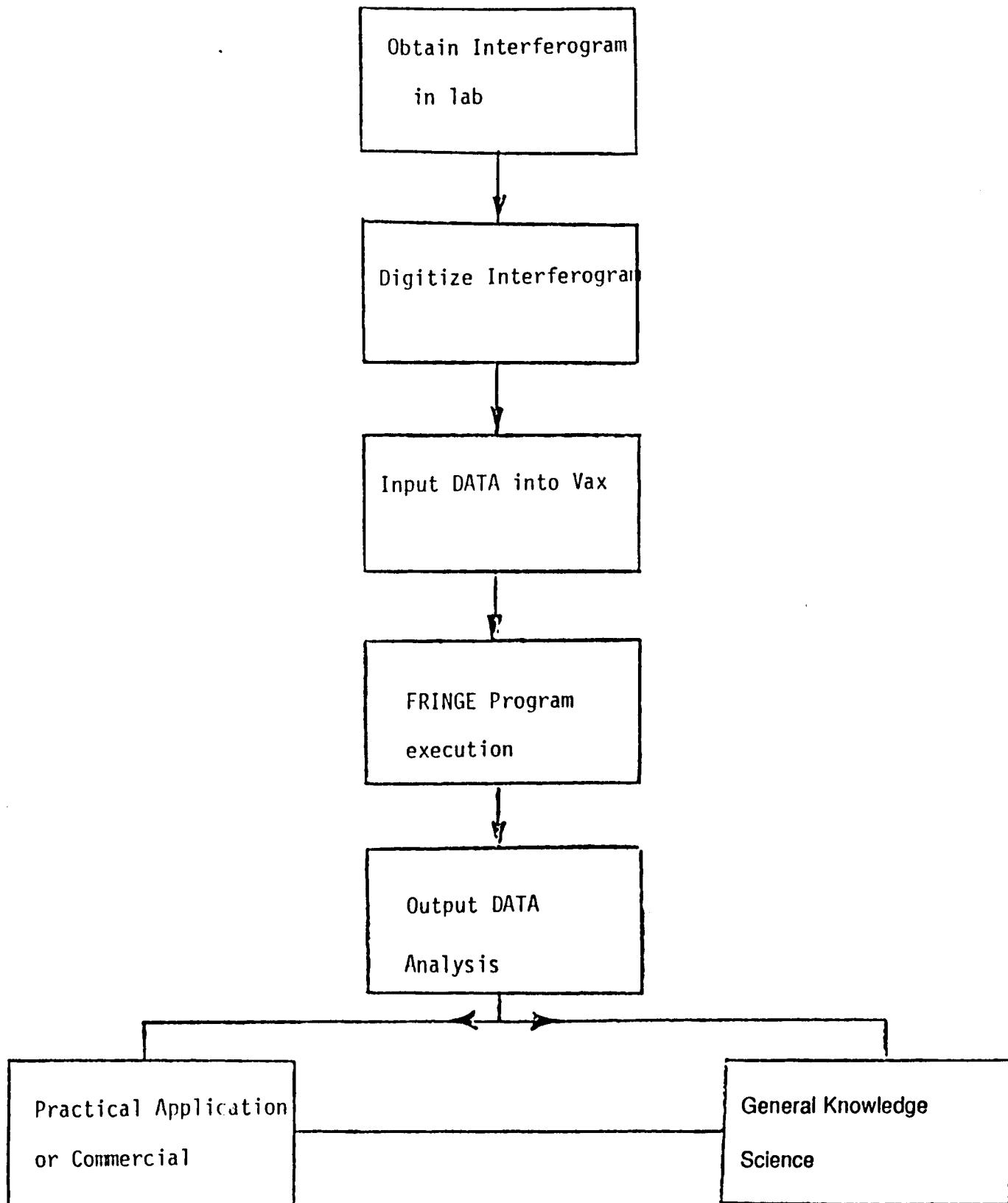


Figure E1.- Fringe analysis process flowchart.